OBSOLETE



54ACQ244, 54ACTQ244

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# 54ACQ244 • 54ACTQ244 Quiet Series Octal Buffer/Line Driver with TRI-STATE Outputs

Check for Samples: 54ACQ244, 54ACTQ244

### **FEATURES**

- I<sub>CC</sub> and I<sub>OZ</sub> Reduced by 50%
- **Ensured Simultaneous Switching Noise Level** • and Dynamic Threshold Performance
- Improved Latch-Up Immunity
- **TRI-STATE Outputs Drive Bus Lines or Buffer** Memory Address Registers
- **Outputs Source/Sink 24 mA** .
- Faster Prop Delays than the Standard 'AC/'ACT244
- **4 kV Minimum ESD Immunity**
- Standard Microcircuit Drawing (SMD)
  - 'ACTQ244: 5962-92186
  - 'ACQ244: 5962-92176

### Logic Symbol

## DESCRIPTION

The 'ACQ/'ACTQ244 is an octal buffer and line driver designed to be employed as a memory address driver, clock driver and bus oriented transmitter or receiver which provides improved PC board density. The ACQ/ACTQ utilizes TI Quiet Series technology to ensure quiet output switching and improved dynamic threshold performance. FACT Quiet Series™ features GTO<sup>™</sup> output control and undershoot corrector in addition to a split ground bus for superior performance.

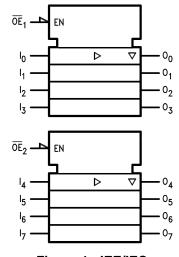


Figure 1. IEE/IEC

Pin Names	Description
$\overline{OE}_1, \overline{OE}_2$	TRI-STATE Output Enable Inputs
I <sub>0</sub> —I <sub>7</sub>	Inputs
O <sub>0</sub> –O <sub>7</sub>	Outputs



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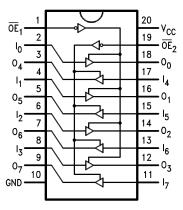
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#### **Connection Diagrams**





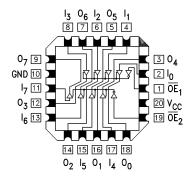


Figure 3. Pin Assignment for LCCC

Truth	Table
mun	Iable

Inpu	uts	Outputs
OE <sub>1</sub>	I <sub>n</sub>	(Pins 12, 14, 16, 18)
L	L	L
L	Н	н
н	х	Z
Inpu	uts	Outputs
OE <sub>2</sub>	l <sub>n</sub>	(Pins 3, 5, 7, 9)
L	L	L
L	Н	н
н	х	Z
H = HIGH VoltagL = LOW VoltagX = ImmaterialZ = High Impeda	e Level	



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### Absolute Maximum Ratings<sup>(1)(2)</sup>

Supply Voltage (V <sub>CC</sub> )		-0.5V to +7.0V
	V <sub>1</sub> = -0.5V	-20 mA
DC Input Diode Current (I <sub>IK</sub> )	$V_{I} = V_{CC} + 0.5V$	+20 mA
DC Input Voltage (VI)	Voltage (V <sub>I</sub> )	
DC Output Diada Current (L.)	$V_{O} = -0.5V$	-20 mA
DC Output Diode Current (I <sub>OK</sub> )	$V_{\rm O} = V_{\rm CC} + 0.5 V$	+20 mA
DC Output Voltage (V <sub>O</sub> )		-0.5V to V <sub>CC</sub> + 0.5V
DC Output Source or Sink Current (I <sub>O</sub> )		±50 mA
DC $V_{CC}$ or Ground Current per Output Pin (I <sub>CC</sub> or	I <sub>GND</sub> )	±50 mA
Storage Temperature (T <sub>STG</sub> )		−65°C to +150°C
DC Latch-Up Source or Sink Current		±300 mA
Junction Temperature (T <sub>J</sub> )	CDIP	175°C

(1) Absolute Maximum Ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. TI does not recommend operation of FACT<sup>®</sup> circuits outside databook specifications.

(2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.

### **Recommended Operating Conditions**

	'ACQ	2.0V to 6.0V
Supply Voltage (V <sub>CC</sub> )	'ACTQ	4.5V to 5.5V
Input Voltage (VI)		0V to V <sub>CC</sub>
Output Voltage (V <sub>O</sub> )		0V to V <sub>CC</sub>
Operating Temperature (T <sub>A</sub> )	54ACQ/ACTQ	−55°C to +125°C
Minimum Input Edge Rate ΔV/Δt 'ACQ Devices	$V_{\text{IN}}$ from 30% to 70% of $V_{\text{CC}}$	
	V <sub>CC</sub> @ 3.0V, 4.5V, 5.5V	125 mV/ns
	V <sub>IN</sub> from 0.8V to 2.0V	
Minimum Input Edge Rate ΔV/Δt 'ACTQ Devices	V <sub>CC</sub> @ 4.5V, 5.5V	125 mV/ns

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#### **DC Electrical Characteristics for 'ACQ Family Devices**

			54ACQ		
Symbol	Parameter	V <sub>cc</sub>	T <sub>A</sub> = −55°C to +125°C	Units	Conditions
		(V)	Ensured Limits		
V <sub>IH</sub>	Minimum High Level	3.0	2.1		V <sub>OUT</sub> = 0.1V
	Input Voltage	4.5	3.15	V	or V <sub>CC</sub> – 0.1V
		5.5	3.85		
V <sub>IL</sub>	Maximum Low Level	3.0	0.9		V <sub>OUT</sub> = 0.1V
	Input Voltage	4.5	1.35	V	or V <sub>CC</sub> – 0.1V
		5.5	1.65		
V <sub>OH</sub>	Minimum High Level	3.0	2.9		I <sub>OUT</sub> = −50 μA
	Output Voltage	4.5	4.4	V	
		5.5	5.4		
					See <sup>(1)</sup>
					$V_{IN} = V_{IL} \text{ or } V_{IH}$
		3.0	2.4		I <sub>OH</sub> = −12 mA
		4.5	3.7	V	I <sub>OH</sub> = −24 mA
		5.5	4.7		I <sub>OH</sub> = −24 mA
V <sub>OL</sub>	Maximum Low Level	3.0	0.1		I <sub>OUT</sub> = 50 μA
	Output Voltage	4.5	0.1	V	
		5.5	0.1		(4)
		3.0	0.50		I <sub>OL</sub> = 12 mA
		4.5	0.50	V	I <sub>OL</sub> = 24 mA
		5.5	0.50		I <sub>OL</sub> = 24 mA
I <sub>IN</sub>	Maximum Input	5.5	±1.0	μA	$V_I = V_{CC}, GND^{(2)}$
	Leakage Current				
I <sub>OLD</sub>	Minimum Dynamic	5.5	50	mA	$V_{OLD}$ = 1.65V Max
I <sub>OHD</sub>	Output Current <sup>(3)</sup>	5.5	-50	mA	V <sub>OHD</sub> = 3.85V Min
I <sub>CC</sub>	Maximum Quiescent	5.5	80.0	μA	$V_{IN} = V_{CC}$
	Supply Current				or GND <sup>(2)</sup>
I <sub>OZ</sub>	Maximum TRI-STATE				$V_{I}(OE) = V_{IL}, V_{IH}$
	Leakage Current	5.5	±5.0	μA	$V_{I} = V_{CC}, GND$
					$V_{O} = V_{CC}, GND$
V <sub>OLP</sub>	Quiet Output	5.0	1.5	V	See <sup>(4)(5)</sup>
	Maximum Dynamic V <sub>OL</sub>				
V <sub>OLV</sub>	Quiet Output	5.0	-1.2	V	See <sup>(4)(5)</sup>
	Minimum Dynamic V <sub>OL</sub>				

All outputs loaded thresholds on input associated with output under test. (1)

 $I_{\rm IN}$  and  $I_{\rm CC}$  @ 3.0V are ensured to be less than or equal to the respective limit @ 5.5V V<sub>CC</sub>.I<sub>CC</sub> for 54ACQ @ 25°C is identical to 74ACQ @ 25°C. (2)

Maximum test duration 2.0 ms, one output loaded at a time. (3)

(4) PDIP package.

(5) Max number of outputs defined as (n). Data Inputs are driven 0V to 5V. One output @ GND.

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54ACTQ					
Parameter	V <sub>cc</sub>	-55°C to +125°C	Units	Conditions	
	(V)	Ensured Limits			
Minimum High Level	4.5	2.0	V	V <sub>OUT</sub> = 0.1V	
Input Voltage	5.5	2.0		or $V_{CC}$ – 0.1V	
Maximum Low Level	4.5	0.8	V	$V_{OUT} = 0.1V$	
Input Voltage	5.5	0.8		or $V_{CC}$ – 0.1V	
Minimum High Level	4.5	4.4	V	I <sub>OUT</sub> = -50 μA	
Output Voltage	5.5	5.4			
				$\frac{\text{See}^{(1)}}{\text{V}_{\text{IN}} = \text{V}_{\text{IL}} \text{ or } \text{V}_{\text{IH}}}$	
	4.5	3.70	V	I <sub>OH</sub> = −24 mA	
	5.5	4.70		I <sub>OH</sub> = −24 mA	
Maximum Low Level	4.5	0.1	V	I <sub>OUT</sub> = 50 μA	
Output Voltage	5.5	0.1			
				$      See^{(1)} \\ V_{IN} = V_{IL} \text{ or } V_{IH} $	
	4.5	0.50	V	I <sub>OL</sub> = 24 mA	
	5.5	0.50		I <sub>OL</sub> = 24 mA	
Maximum Input	5.5	±1.0	μA	$V_I = V_{CC}, GND$	
-		·E 0		$V_{I} = V_{IL}, V_{IH}$	
	5.5	±5.0	μΑ		
-	5.5	1.6	mA	$V_0 = V_{CC}$ , GND $V_1 = V_{CC} - 2.1V$	
				$V_1 = V_{CC} - 2.1V$ $V_{OLD} = 1.65V$ Max	
				$V_{OLD} = 1.05V Max$ $V_{OHD} = 3.85V Min$	
				$V_{\rm IN} = V_{\rm CC}$	
	0.0	00.0	μ.,	or $GND^{(3)}$	
	5.0	1.5	V	See <sup>(4) (5)</sup>	
	0.0	1.0	v		
	5.0	-12	V	See <sup>(4) (5)</sup>	
	0.0	1.2	v		
	Minimum High Level Input Voltage Maximum Low Level Input Voltage Minimum High Level Output Voltage Maximum Low Level Output Voltage	No.No.Minimum High Level4.5Input Voltage5.5Maximum Low Level4.5Input Voltage5.5Minimum High Level4.5Output Voltage5.5Maximum Low Level4.5Output Voltage5.5Maximum Low Level4.5Output Voltage5.5Maximum Low Level4.5Output Voltage5.5Maximum Low Level4.5Output Voltage5.5Maximum Input5.5Leakage Current5.5Maximum Input5.5Leakage Current5.5Maximum Ucc/Input5.5Maximum Quiescent5.5Supply Current5.5Quiet Output5.0Maximum Dynamic $V_{OL}$ 5.0Quiet Output5.0	(V)         Ensured Limits           Minimum High Level         4.5         2.0           Input Voltage         5.5         2.0           Maximum Low Level         4.5         0.8           Input Voltage         5.5         0.8           Minimum High Level         4.5         4.4           Output Voltage         5.5         5.4           Maximum Low Level         4.5         3.70           5.5         5.4         5.5           Maximum Low Level         4.5         0.1           Output Voltage         5.5         0.1           Maximum Low Level         4.5         0.1           Output Voltage         5.5         0.50           Maximum Input         5.5         0.50           Leakage Current         5.5         1.0           Maximum Input         5.5         1.6           Maximum Nopamic <sup>(2)</sup> 5.5         50           Output Current         5.5         50           Maximum Quiescent         5.5         80.0           Supply Current         5.0         1.5           Quiet Output         5.0         1.5           Maximum Dynamic V <sub>OL</sub> 7.0         1.5 </td <td>(V)         Ensured Limits           Minimum High Level         4.5         2.0         V           Input Voltage         5.5         2.0         V           Maximum Low Level         4.5         0.8         V           Input Voltage         5.5         0.8         V           Minimum High Level         4.5         4.4         V           Output Voltage         5.5         5.4         V           Maximum Low Level         4.5         3.70         V           4.5         3.70         V         5.5         4.70           Maximum Low Level         4.5         0.1         V           Output Voltage         5.5         0.50         V           Maximum Input         5.5         9.5         0.50         V           Maximum Input         5.5         1.6         mA           Leakage Current         5.5         50         mA           Maximum Input         5.5         50         mA           Leakage Current         5.5         9.5         mA           Maximum Input         5.5         50         mA           Quipt Current         5.5         80.0         µA</td>	(V)         Ensured Limits           Minimum High Level         4.5         2.0         V           Input Voltage         5.5         2.0         V           Maximum Low Level         4.5         0.8         V           Input Voltage         5.5         0.8         V           Minimum High Level         4.5         4.4         V           Output Voltage         5.5         5.4         V           Maximum Low Level         4.5         3.70         V           4.5         3.70         V         5.5         4.70           Maximum Low Level         4.5         0.1         V           Output Voltage         5.5         0.50         V           Maximum Input         5.5         9.5         0.50         V           Maximum Input         5.5         1.6         mA           Leakage Current         5.5         50         mA           Maximum Input         5.5         50         mA           Leakage Current         5.5         9.5         mA           Maximum Input         5.5         50         mA           Quipt Current         5.5         80.0         µA	

(1) All outputs loaded thresholds on input associated with output under test.

(2) Maximum test duration 2.0 ms, one output loaded at a time.

(3) I<sub>CC</sub> for 54ACTQ @ 25°C is identical to 74ACTQ @ 25°C.

(4) PDIP package.

(5) Max number of outputs defined as (n). Data Inputs are driven 0V to 3V. One output @ GND.



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#### **AC Electrical Characteristics**

Symbol	Parameter	V <sub>CC</sub> (V) <sup>(1)</sup>	$V_{CC}$ $T_A = -52$ (V) <sup>(1)</sup> to +125		54ACQ T <sub>A</sub> = -55°C to +125°C C <sub>L</sub> = 50 pF		$V_{CC}$ $T_A = -55^{\circ}C$ $(V)^{(1)}$ to +125^{\circ}C         Units		Units	Fig. No.
			Min	Max						
t <sub>PHL,</sub> t <sub>PLH</sub>	Propagation Delay	3.3	1.0	12.5	ns					
	Data to Output	5.0	1.0	9.0						
t <sub>PZL,</sub> t <sub>PZH</sub>	Output Enable Time	3.3	1.0	12.0	ns					
		5.0	1.0	10.0						
t <sub>PHZ,</sub> t <sub>PLZ</sub>	Output Disable Time	3.3	1.0	11.5	ns					
		5.0	1.0	10.0						

(1) Voltage Range 5.0 is 5.0V  $\pm$ 0.5V. Voltage Range 3.3 is 3.3V  $\pm$ 0.3V.

### **AC Electrical Characteristics**

Symbol	Parameter	V <sub>CC</sub> (V) <sup>(1)</sup>	T <sub>A</sub> = to +2	CTQ –55°C I25°C 50 pF	Units	Fig. No.
			Min	Мах		
t <sub>PHL</sub> , t <sub>PLH</sub>	Propagation Delay	5.0	1.5	9.0	ns	
	Data to Output					
t <sub>PZL</sub> , t <sub>PZH</sub>	Output Enable Time	5.0	1.5	10.5	ns	
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Output Disable Time	5.0	1.5	10.5	ns	

(1) Voltage Range 5.0 is  $5.0V \pm 0.5V$ .

#### Capacitance

Symbol	Parameter	Тур	Units	Conditions
C <sub>IN</sub>	Input Capacitance	4.5	pF	V <sub>CC</sub> = OPEN
C <sub>PD</sub>	Power Dissipation Capacitance	70	pF	$V_{CC} = 5.0V$

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#### **REVISION HISTORY**

Changes	from	Revision	Δ	(An	ril (	2013)	to	Revision	R
Changes	nom	Revision	А	(AP		2013)	ιο	Revision	D

<ul> <li>Chang</li> </ul>	yout of National Data Sheet to TI format
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